

<b>Notice of References Cited</b>	Application/Control No. 09/403,429	Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner Susan T. Tran	Art Unit 1615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,026,560	06-1991	Makino et al.	424/494
	B	US-5,958,453	09-1999	Ohno et al.	424/465
	C	US-6,365,184	04-2002	Depui et al.	424/469
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0 890 359 A1	01-1999	European	Yamaguchi et al.	
	O	EP 0 965 339 A1	12-1999	European	Yabuki et al.	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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